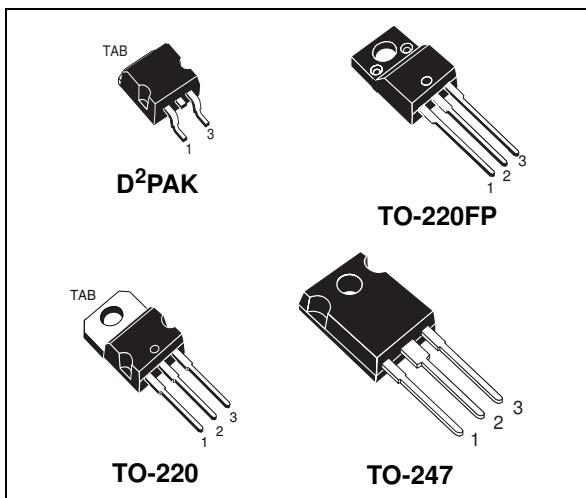


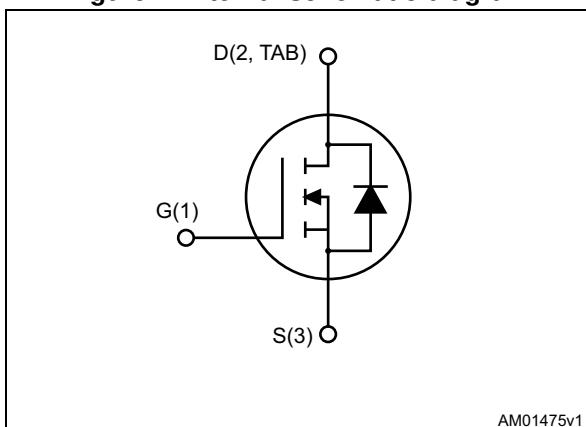
# STB18NM60ND, STF18NM60ND, STP18NM60ND, STW18NM60ND

N-channel 600 V - 0.25  $\Omega$  typ., 13 A FDmesh™ II Power MOSFET  
(with fast diode) in D<sup>2</sup>PAK, TO-220FP, TO-220 and TO-247 packages

Datasheet – production data



**Figure 1. Internal schematic diagram**



## Features

Order codes	$V_{DSS} @ T_{Jmax}$	$R_{DS(on)} \text{ max}$	$I_D$
STB18NM60ND	650 V	<0.29 $\Omega$	13 A
STF18NM60ND			
STP18NM60ND			
STW18NM60ND			

- The worldwide best  $R_{DS(on)}$ \* area amongst the fast recovery diode devices
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance
- Extremely high dv/dt and avalanche capabilities

## Applications

- Switching applications

## Description

These FDmesh™ II Power MOSFETs with intrinsic fast-recovery body diode are produced using the second generation of MDmesh™ technology. Utilizing a new strip-layout vertical structure, these revolutionary devices feature extremely low on-resistance and superior switching performance. They are ideal for bridge topologies and ZVS phase-shift converters.

**Table 1. Device summary**

Order codes	Marking	Package	Packaging
STB18NM60ND	18NM60ND	D <sup>2</sup> PAK	Tape and reel
STF18NM60ND		TO-220FP	
STP18NM60ND		TO-220	
STW18NM60ND		TO-247	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		D <sup>2</sup> PAK, TO-220, TO-247	TO-220FP	
V <sub>DS</sub>	Drain-source voltage	600		V
V <sub>GS</sub>	Gate-source voltage	± 25		V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	13	13 <sup>(1)</sup>	A
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	8.19	8.19 <sup>(1)</sup>	A
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	52	52 <sup>(1)</sup>	A
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	130	30	W
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	40		V/ns
dv/dt <sup>(4)</sup>	MOSFET dv/dt ruggedness	40		V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T <sub>C</sub> =25 °C)	--	2500	V
T <sub>stg</sub>	Storage temperature	-55 to 150		°C
T <sub>j</sub>	Operating junction temperature	150		°C

1. Limited by maximum junction temperature
2. Pulse width limited by safe operating area
3. I<sub>SD</sub> ≤ 13 A, di/dt ≤ 400 A/μs, V<sub>DD</sub> = 80% V<sub>(BR)DSS</sub>, V<sub>DS(peak)</sub> ≤ V<sub>(BR)DSS</sub>
4. V<sub>DS</sub> ≤ 480 V

**Table 3. Thermal data**

Symbol	Parameter	D <sup>2</sup> PAK	TO-220FP	TO-220	TO-247	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.96	4.17	0.96	0.96	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-amb max		62.5		50	°C/W
R <sub>thj-pcb</sub>	Thermal resistance junction-pcb max	30				°C/W

**Table 4. Avalanche characteristics**

Symbol	Parameter	Max value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by T <sub>j</sub> max)	3.5	A
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AS</sub> , V <sub>DD</sub> = 50 V)	187	mJ

## 2 Electrical characteristics

( $T_{CASE}=25^\circ\text{C}$  unless otherwise specified)

**Table 5. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	600			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_C = 125^\circ\text{C}$			1 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$		0.25	0.29	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$	-	1030	-	pF
$C_{oss}$	Output capacitance		-	30	-	pF
$C_{rss}$	Reverse transfer capacitance		-	3.2	-	pF
$C_{oss \text{ eq.}}^{(1)}$	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0 \text{ V to } 480 \text{ V}$	-	148	-	pF
$R_g$	Gate input resistance	$f = 1 \text{ MHz}$ Gate DC Bias=0 Test signal level=20 mV open drain	-	3.6	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 13 \text{ A}$ $V_{GS} = 10 \text{ V}$ <i>(see Figure 18)</i>	-	34	-	nC
$Q_{gs}$	Gate-source charge		-	5.5	-	nC
$Q_{gd}$	Gate-drain charge		-	20	-	nC

1.  $C_{oss \text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7. Switching times**

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 6.5 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ <i>(see Figure 17)</i>	-	55	-	ns
$t_r$	Rise time		-	15.5	-	ns
$t_{d(off)}$	Turn-off delay time		-	13	-	ns
$t_f$	Fall time		-	18	-	ns

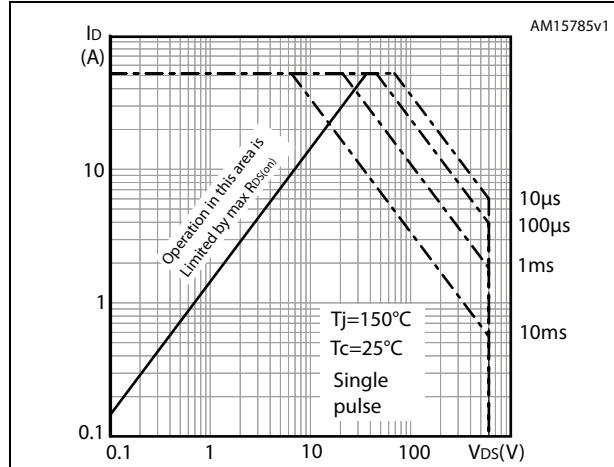
**Table 8. Source drain diode**

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$I_{SD}$	Source-drain current		-		13	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		52	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 13 \text{ A}, V_{GS}=0$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 13 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 100 \text{ V}$ <i>(see Figure 19)</i>	-	136		ns
$Q_{rr}$	Reverse recovery charge		-	843		nC
$I_{RRM}$	Reverse recovery current		-	12.5		A
$t_{rr}$	Reverse recovery time		-	198		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 100 \text{ V}$ $di/dt = 100 \text{ A}/\mu\text{s}, I_{SD} = 13 \text{ A}$	-	1425		nC
$I_{RRM}$	Reverse recovery current	$T_j = 150^\circ\text{C}$ <i>(see Figure 19)</i>	-	14.5		A

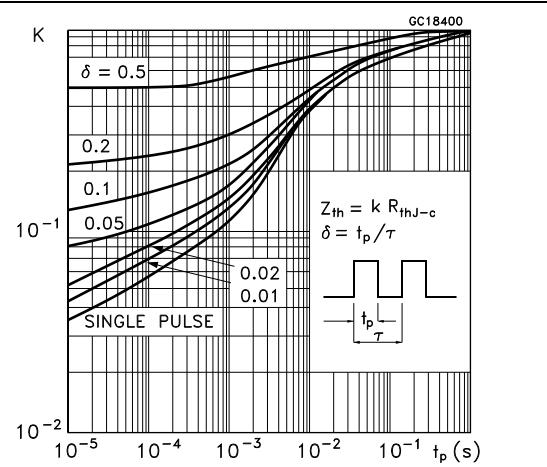
1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

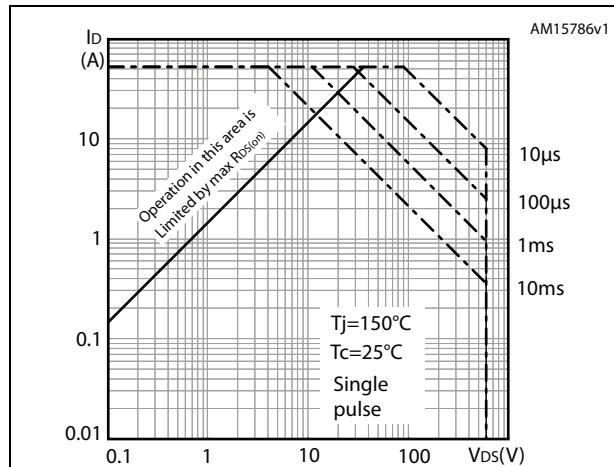
**Figure 2. Safe operating area for D<sup>2</sup>PAK and TO-220**



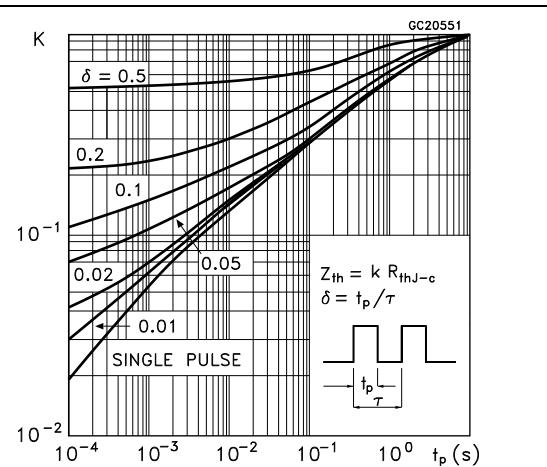
**Figure 3. Thermal impedance for D<sup>2</sup>PAK and TO-220**



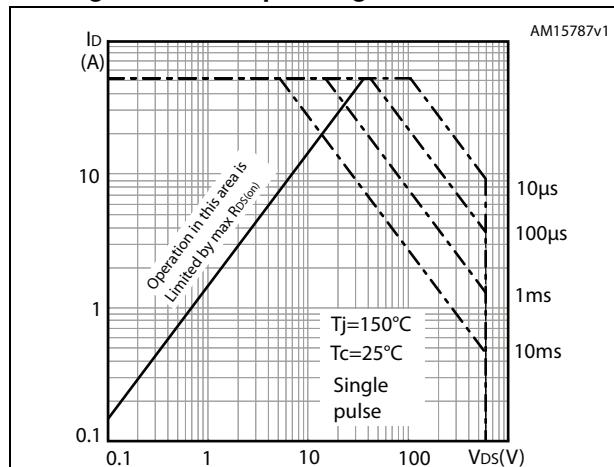
**Figure 4. Safe operating area for TO-220FP**



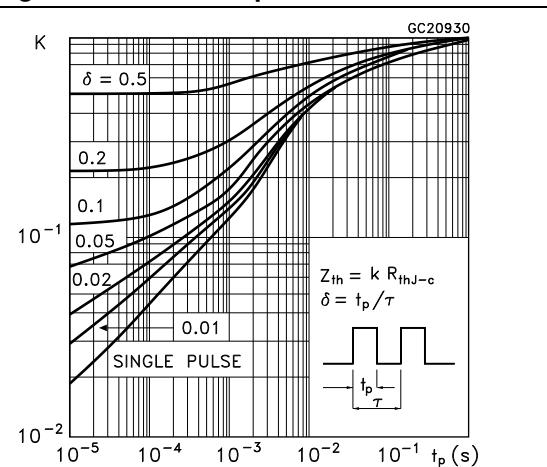
**Figure 5. Thermal impedance for TO-220FP**

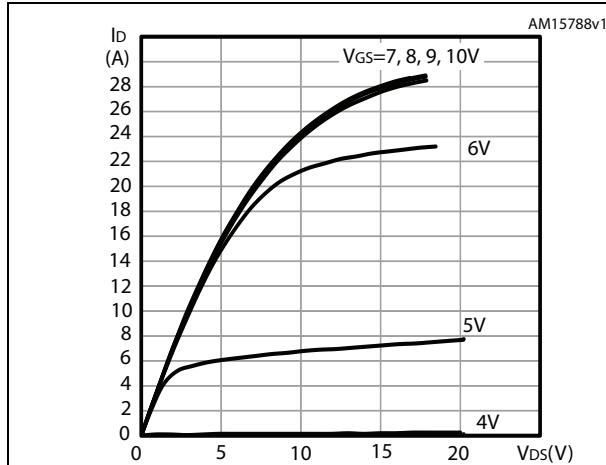
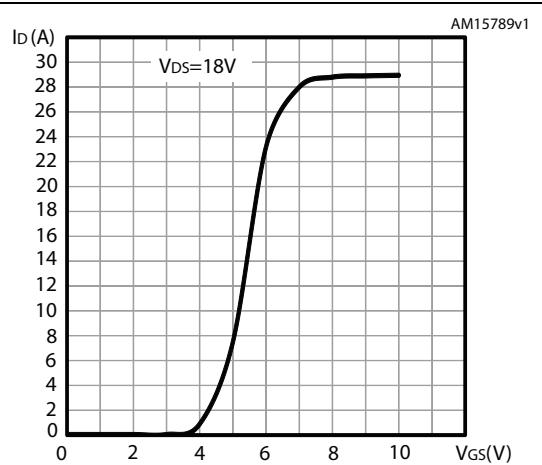
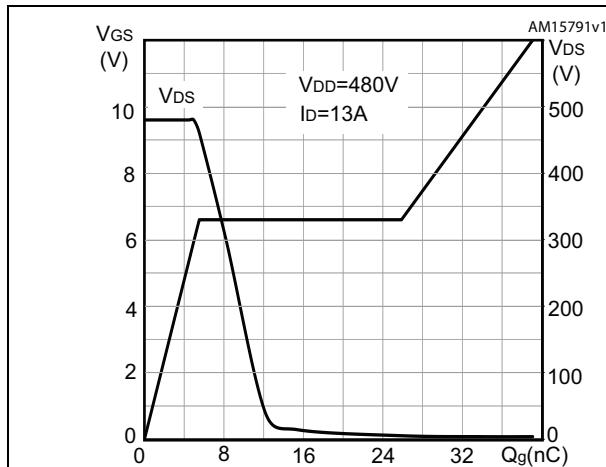
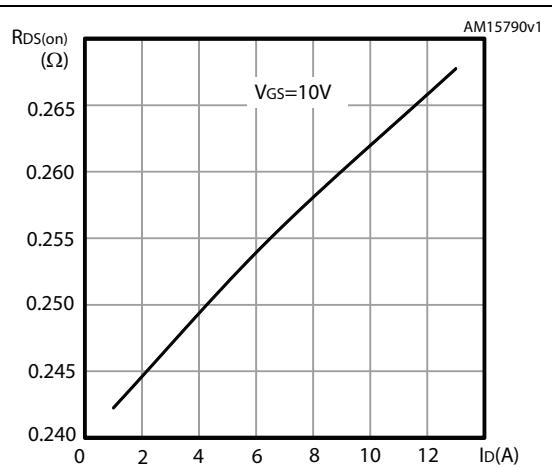
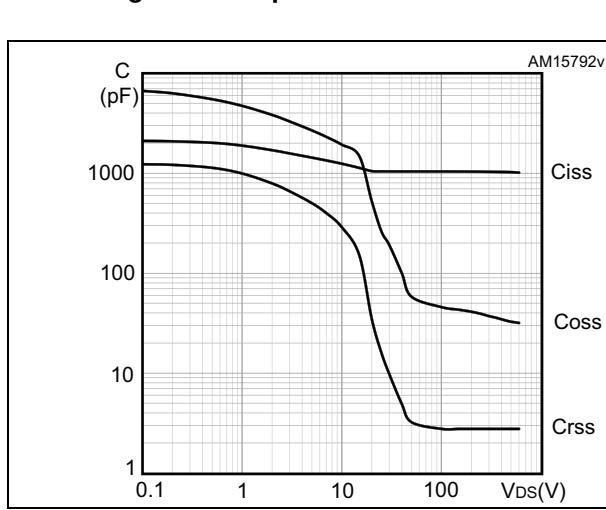
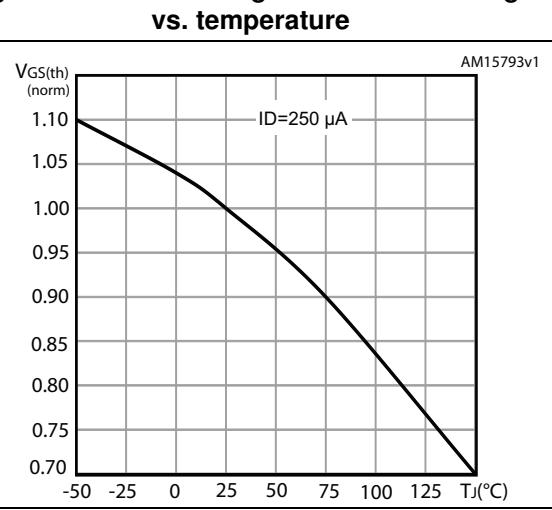


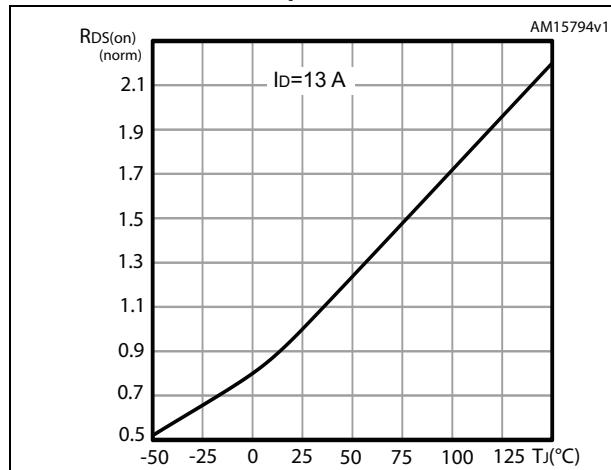
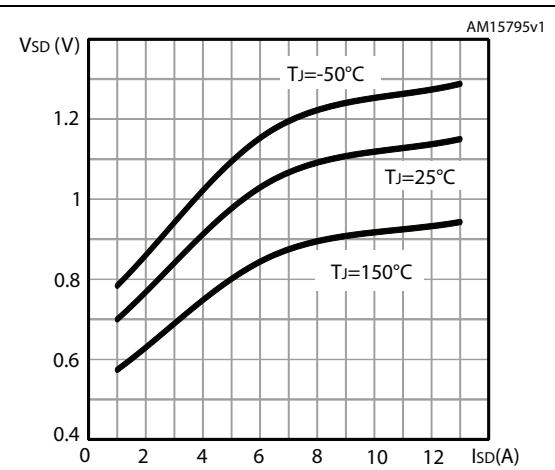
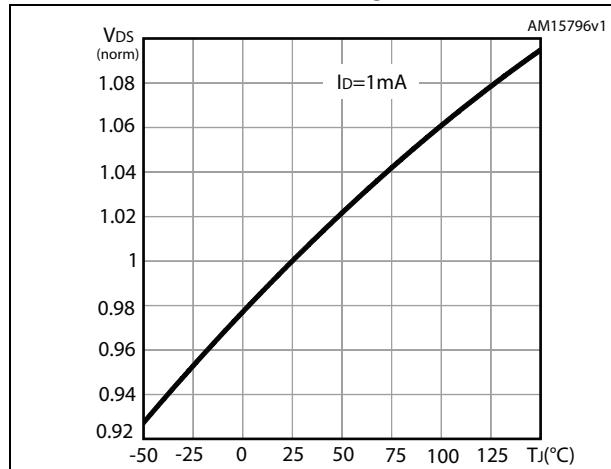
**Figure 6. Safe operating area for TO-247**



**Figure 7. Thermal impedance for TO-247**

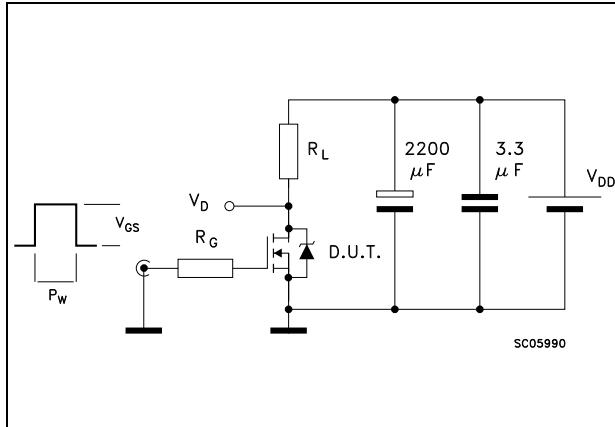


**Figure 8. Output characteristics****Figure 9. Transfer characteristics****Figure 10. Gate charge vs gate-source voltage****Figure 11. Static drain-source on-resistance****Figure 12. Capacitance variations****Figure 13. Normalized gate threshold voltage vs. temperature**

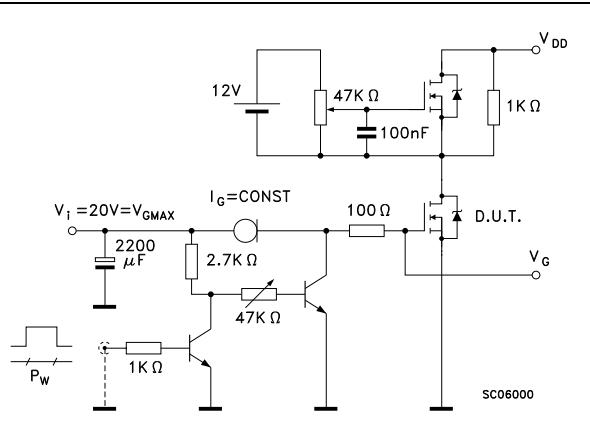
**Figure 14. Normalized on-resistance vs temperature****Figure 15. Source-drain diode forward characteristics****Figure 16. Normalized  $V_{DS}$  vs temperature**

### 3 Test circuit

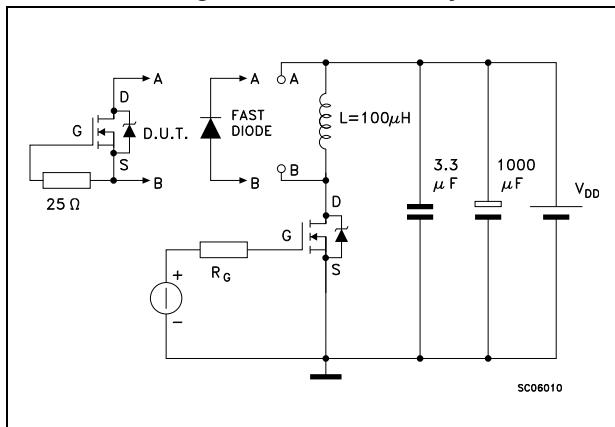
**Figure 17. Switching times test circuit for resistive load**



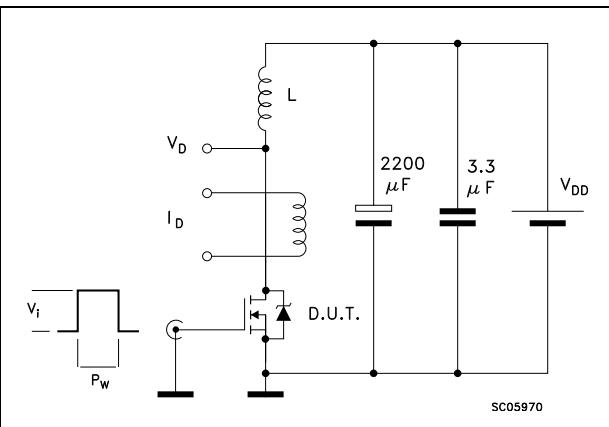
**Figure 18. Gate charge test circuit**



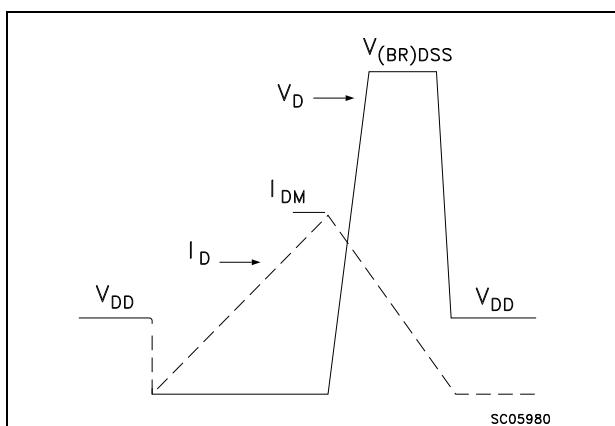
**Figure 19. Test circuit for inductive load switching and diode recovery times**



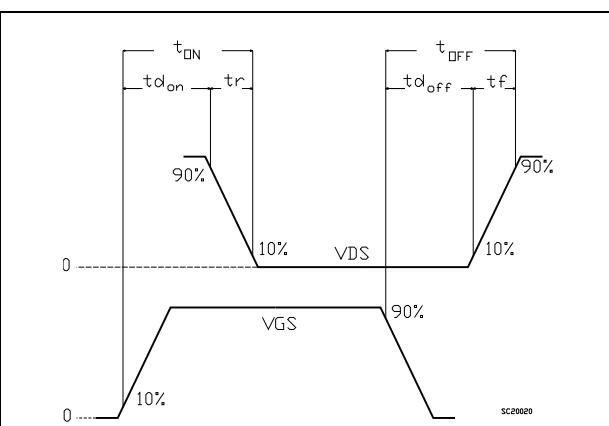
**Figure 20. Unclamped Inductive load test circuit**



**Figure 21. Unclamped inductive waveform**



**Figure 22. Switching time waveform**

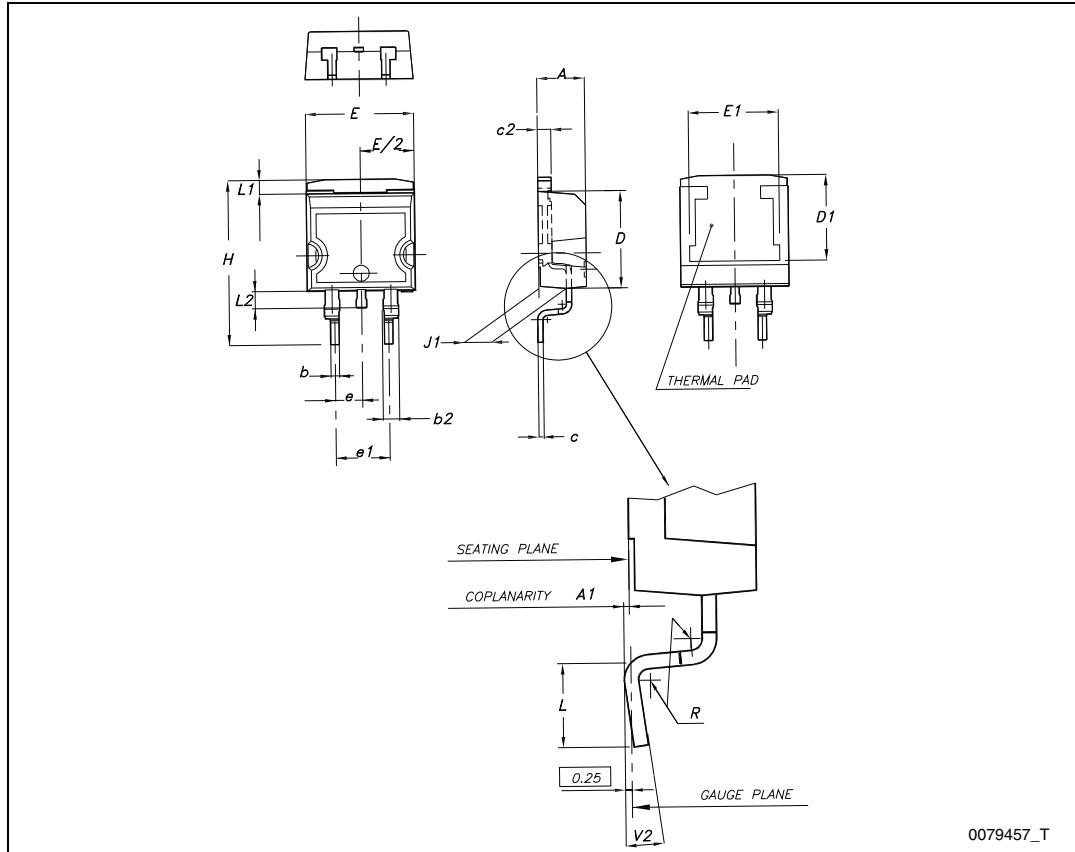
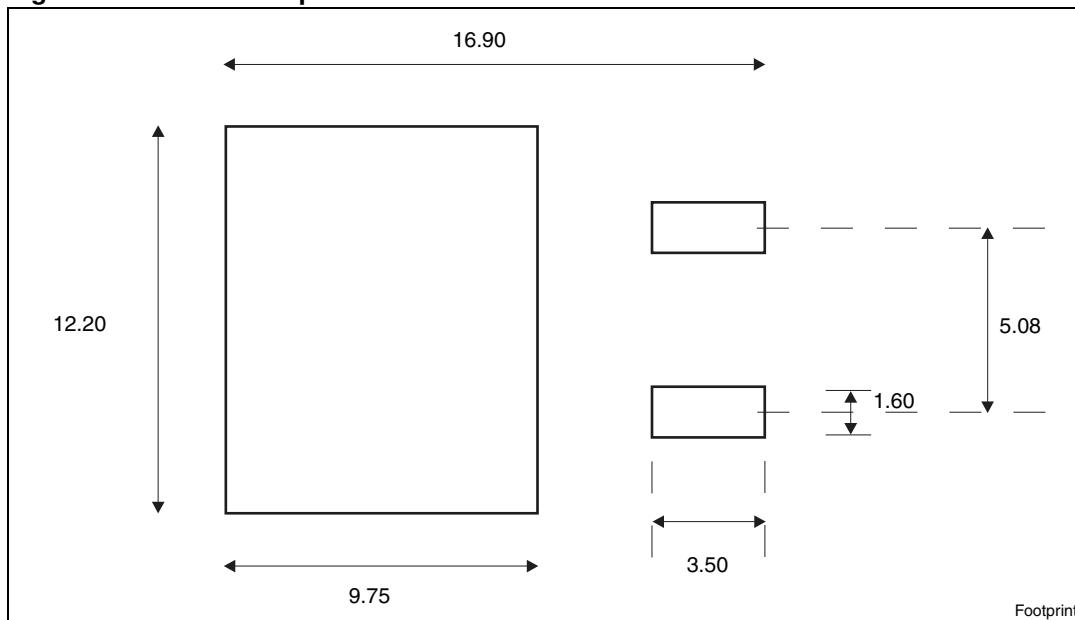


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

**Table 9.** D<sup>2</sup>PAK (TO-263) mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
c	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50		
E	10		10.40
E1	8.50		
e		2.54	
e1	4.88		5.28
H	15		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.4	
V2	0°		8°

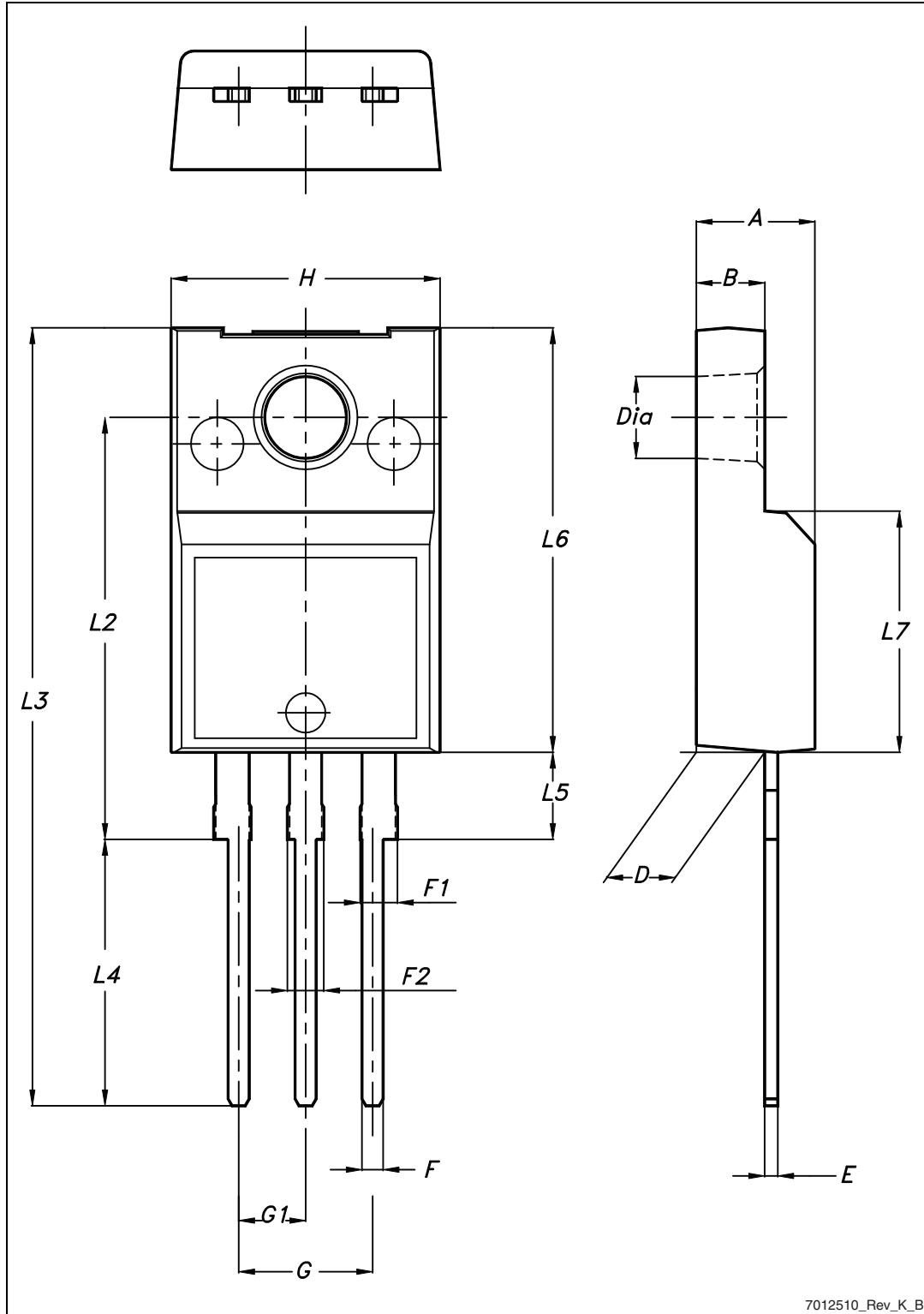
**Figure 23.** D<sup>2</sup>PAK (TO-263) drawing**Figure 24.** D<sup>2</sup>PAK footprint<sup>(a)</sup>

a. All dimension are in millimeters

**Table 10.** TO-220FP mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

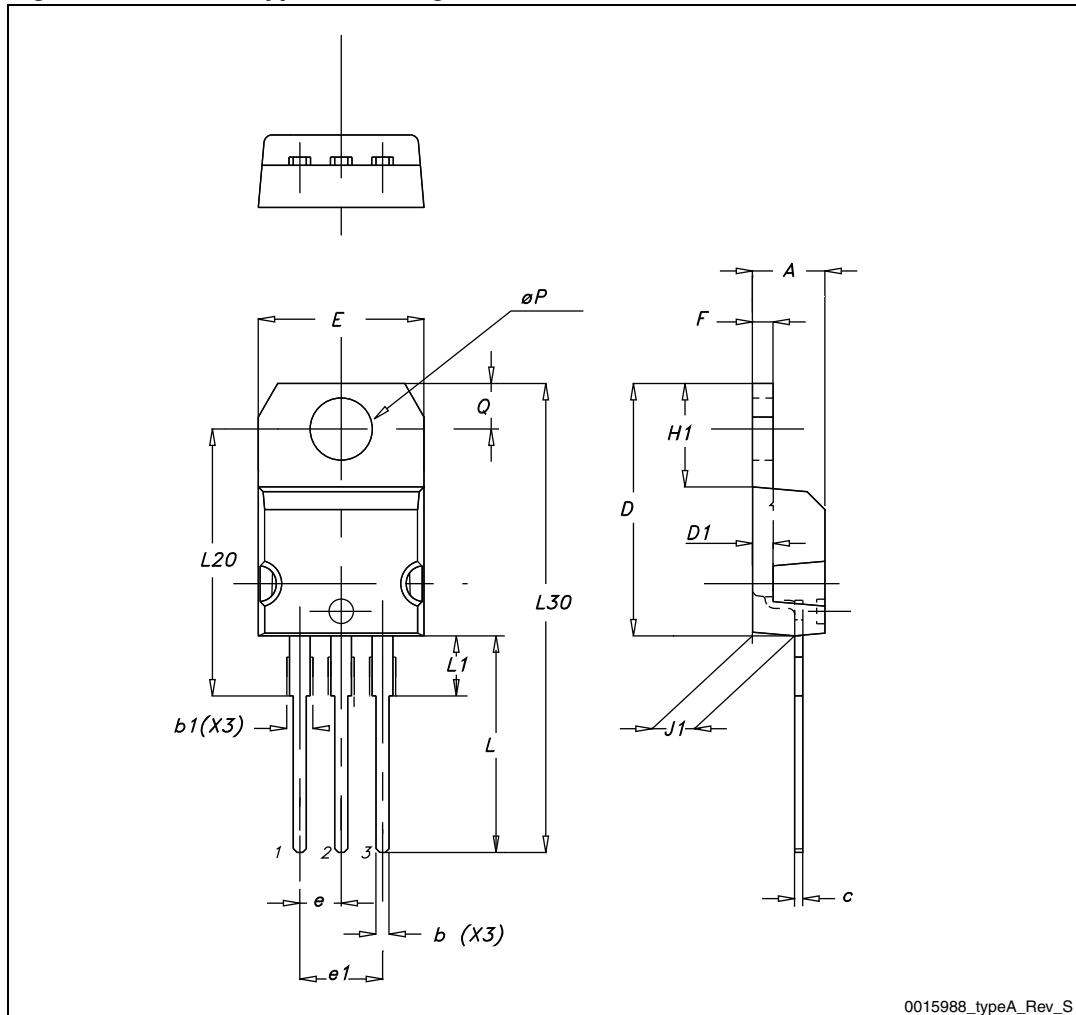
Figure 25. TO-220FP drawing



**Table 11.** TO-220 type A mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

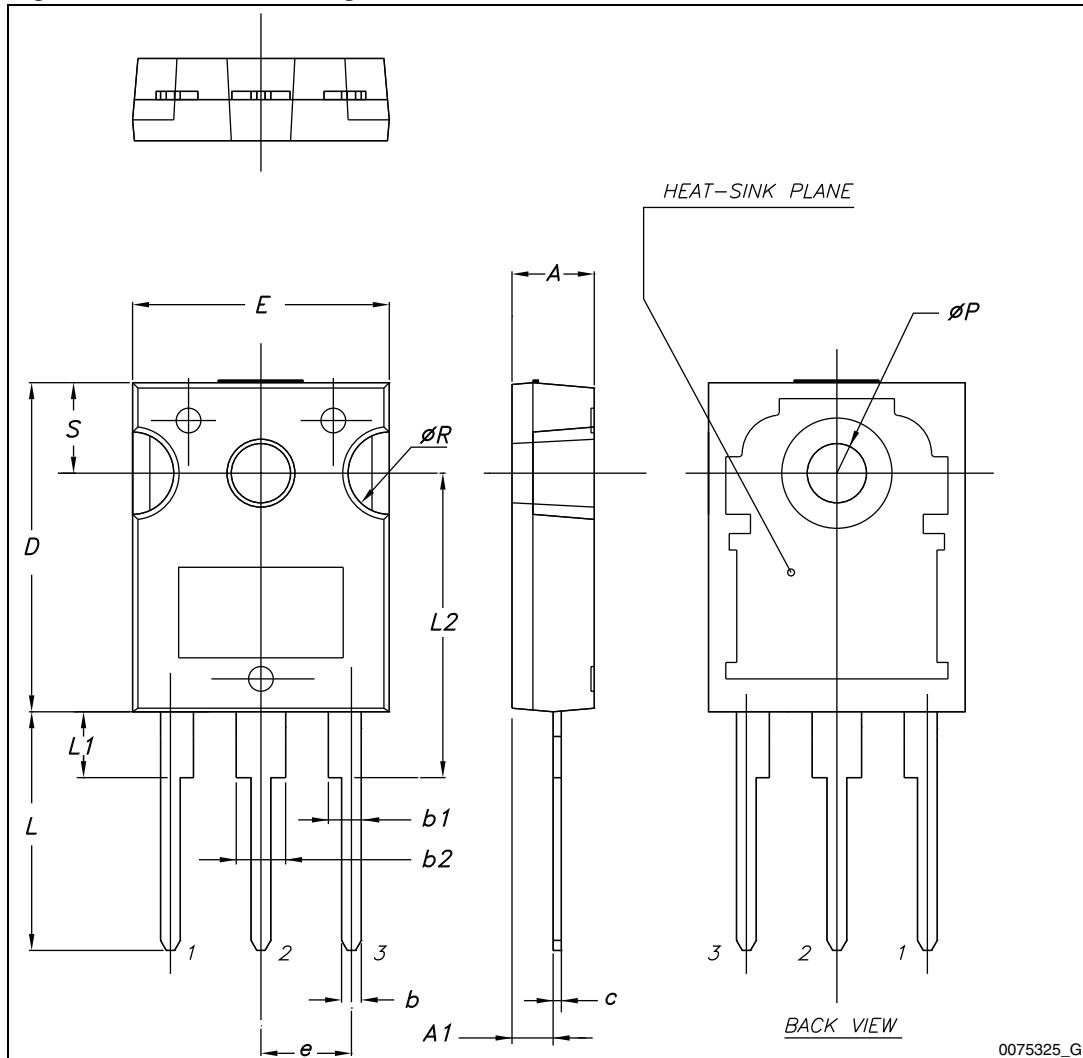
Figure 26. TO-220 type A drawing



**Table 12.** TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

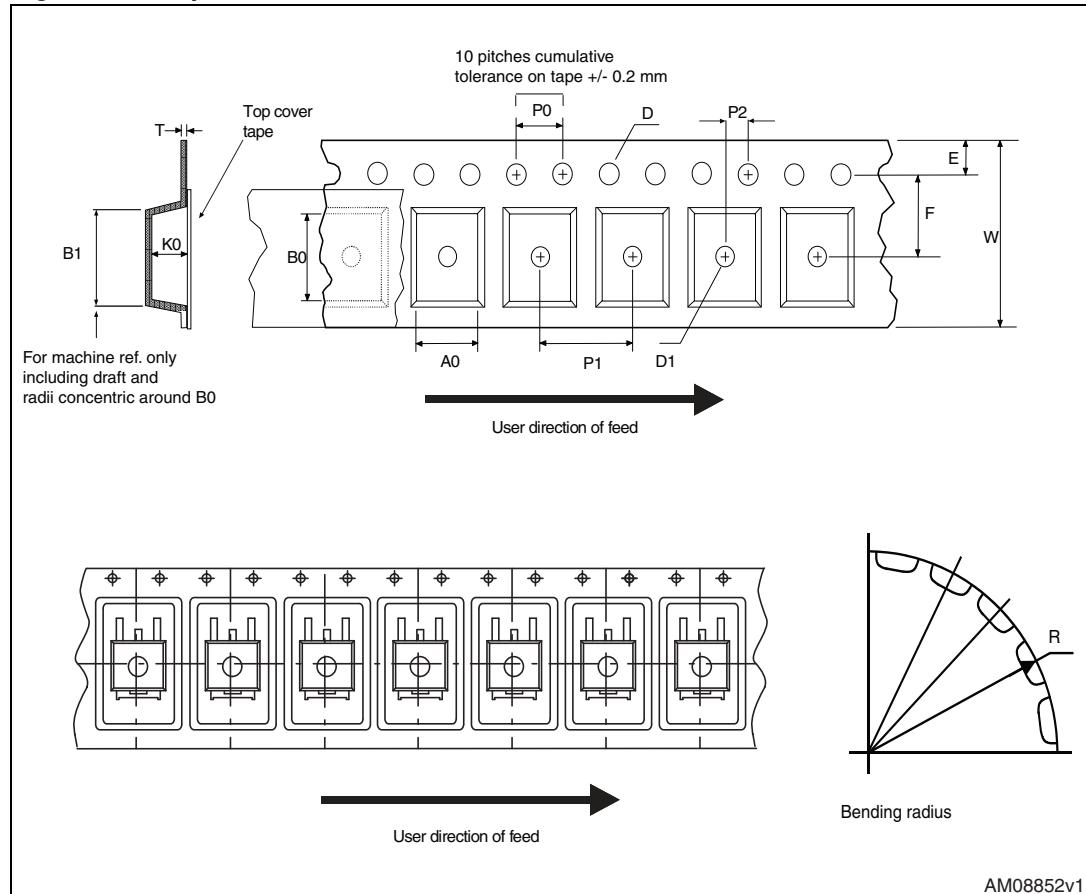
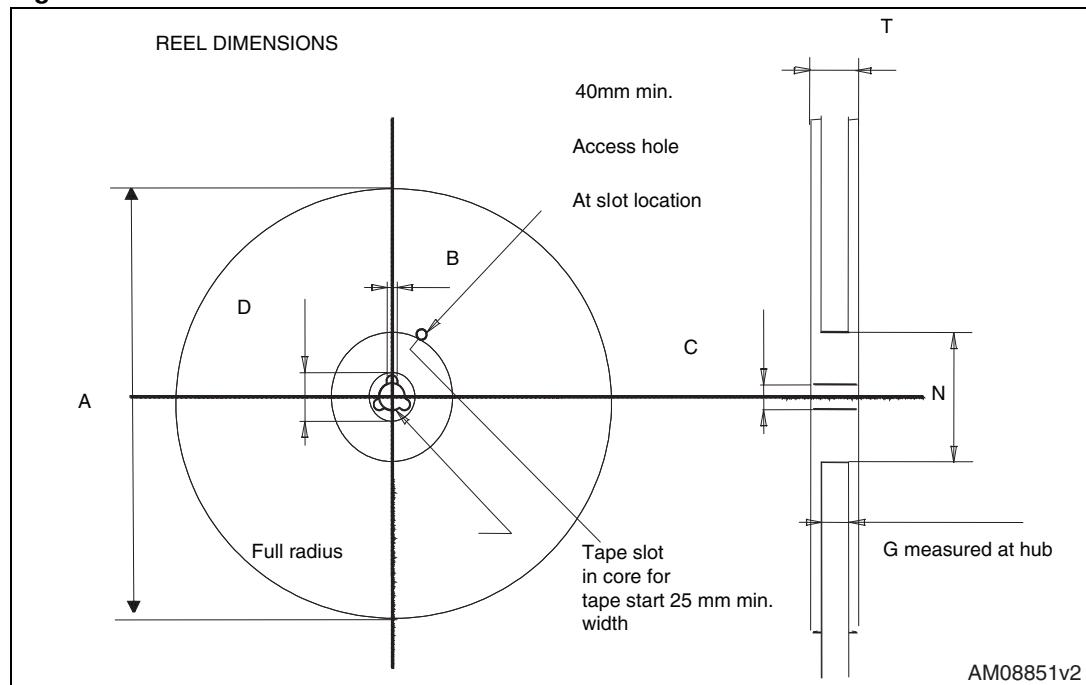
Figure 27. TO-247 drawing



## 5 Packaging mechanical data

**Table 13. D<sup>2</sup>PAK (TO-263) tape and reel mechanical data**

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	10.5	10.7	A		330
B0	15.7	15.9	B	1.5	
D	1.5	1.6	C	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	T		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base qty	1000
P2	1.9	2.1		Bulk qty	1000
R	50				
T	0.25	0.35			
W	23.7	24.3			

**Figure 28. Tape****Figure 29. Reel**

## 6 Revision history

**Table 14. Document revision history**

Date	Revision	Changes
15-May-2013	1	First release

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